

**Search Notes****Application/Control No.**

10/500,596

**Examiner**

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**Applicant(s)/Patent under Reexamination**

ZIEGLER ET AL.

**Art Unit**

2878

**SEARCHED**

Class	Subclass	Date	Examiner
250	225-226	2/23/2006	PL
Updated	search	6/21/2006	PL
356	73.1	6/21/2006	PL
Updated	search	10/26/2006	PL
Updated	search	3/8/2007	PL
Updated	search	6/19/2007	PL
250	227.14	6/19/2007	PL
250	227.15	6/19/2007	PL
250	227.16	6/19/2007	PL
250	227.17	6/19/2007	PL
250	227.18	6/19/2007	PL
250	227.19	6/19/2007	PL
356	462, 464	6/19/2007	PL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference search attached		6/19/2007	PL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted w/ S. Allen AU 2878 CI 250	2/23/2006	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	2/23/2006	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	6/21/2006	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	10/26/2006	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	3/8/2007	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	6/19/2007	PL